

# Preliminary

# SIGC42T60NC

# IGBT Chip in NPT-technology

#### **FEATURES:**

- 600V NPT technology
- 100µm chip
- positive temperature coefficient
- easy paralleling

# This chip is used for:

• IGBT-Modules



# Applications:

• drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC42T60NC	600V	50A	6.5 x 6.5 mm <sup>2</sup>	sawn on foil	Q67041-A4692- A001	

### **MECHANICAL PARAMETER:**

Raster size	6.5 x 6.5				
Area total / active	42.25 / 35.6				
Emitter pad size	2x( 3.0x2.85 )				
Gate pad size	0.8 x 1.5				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	334				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



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### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	70	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	140	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 <b>+</b> 150	°C

# $\textbf{STATIC CHARACTERISTICS} \text{ (tested on chip), } \textit{T}_{j}\text{=}25~^{\circ}\text{C, unless otherwise specified:}$

Parameter	Symbol	Conditions	Value			Unit
Tarameter			min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V, $I_{C}$ =2mA	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =50A	1.7	2.0	2.5	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_C=1mA$ , $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			150	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V, V <sub>GE</sub> =30V			120	nA

## **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei			min.	typ.	max.	Oilit
Input capacitance	Ciss	V <sub>CE</sub> =25V	-	2.2	-	nF
Output capacitance	Coss	V <sub>GE</sub> =0V	-	tbd	-	
Reverse transfer capacitance	Crss	f=1MHz	-	0.2	-	

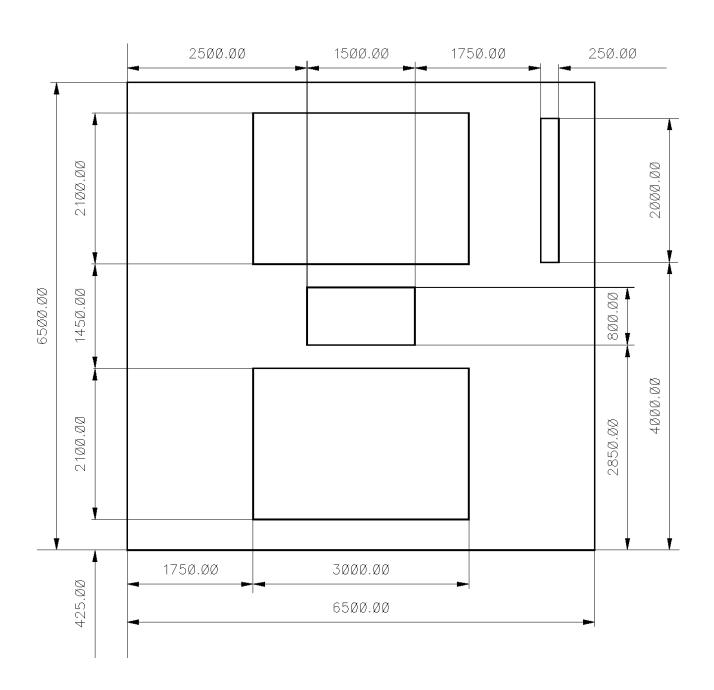
# SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions	Value			Unit
- arameter			min.	typ.	max.	Oiiit
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =125°C V <sub>CC</sub> =300V	-	43	-	ns
Rise time	t <sub>r</sub>	I <sub>C</sub> =50A	-	12	-	
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}}=\pm 15\text{V}$ $R_{\text{G}}=3.3\Omega$	-	130	-	
Fall time	t <sub>f</sub>	/ NG - 0 . 032	-	30	-	



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### **CHIP DRAWING:**





## **Preliminary**

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#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet

FS 50 R06 YL4

#### Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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